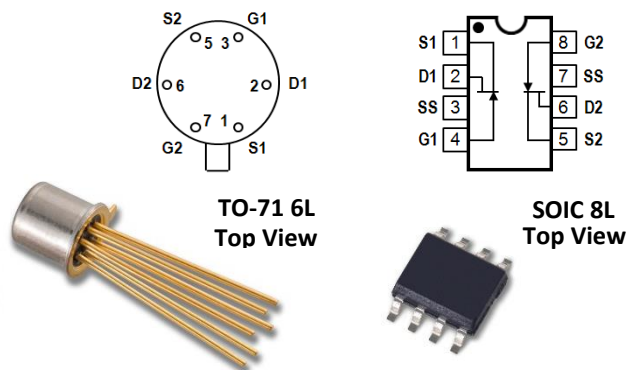


LSK389 A, B, C & D

ABSOLUTE MAXIMUM RATINGS	
@ 25 °C (unless otherwise stated)	
Maximum Temperatures	
Storage Temperature	-65 to +150°C
Junction Operating Temperature	-55 to +135°C
Maximum Power Dissipation	
Continuous Power Dissipation @ +25°C	400mW
Maximum Currents	
Gate Forward Current	$I_{G(F)} = 10\text{mA}$
Maximum Voltages	
Gate to Source	$V_{GSS} = 40\text{V}$
Gate to Drain	$V_{GDS} = 40\text{V}$



Features

- Ultra Low Noise: $e_n = 1.9\text{nV}/\sqrt{\text{Hz}}$ (typ)
- Tight Matching: $|V_{GS1-2}| = 20\text{mV}$ max
- High Breakdown Voltage: $BV_{GSS} = 40\text{V}$ max
- High Gain: $G_{fs} = 20\text{mS}$ (typ)
- Low Capacitance: 25pF typ
- Improved Second Source Replacement for 2sk389

Benefits

- Unique Monolithic Dual Design Construction of Interleaving Both JFETs on the Same Piece of Silicon
- Excellent Matching and Thermal Tracking
- Low Noise Profile Having Nearly Zero Noise
- Great for Maximizing Battery Operated Applications by Providing a Wide Output Swing
- A High Signal to Noise Ratio as a Result of the LSK389's Tightly Matched Gate Threshold Voltages and Low Gate Threshold Voltages

Applications

- Audio Amplifiers and Preamps
- Discrete Low-Noise Operational Amplifiers
- Battery-Operated Audio Preamps
- Audio Mixer Consoles
- Acoustic Sensors
- Sonic Imaging
- Instrumentation Amplifiers Microphones
- Sonobouys
- Hydrophones
- Chemical and Radiation Detectors

Description

The LSK389 Series, Monolithic Dual N-Channel JFETs were specifically designed to provide users a better performing, less time consuming and cheaper solution for obtaining tighter IDSS matching, and better thermal tracking, than matching individual JFETs. The LSK389's features incorporate four grades of IDSS: 2.6-6.5mA, 6.0-12.0mA, 10.0-20.0mA and 17-30mA, with an IDSS match of 10 percent, a gate threshold offset of 20mV, a voltage noise (e_n) of 1.9nV/ $\sqrt{\text{Hz}}$ typical, with a Gain of 20ms typical, and 25pf of capacitance typical. The LSK389 provides a wide output swing, and a high signal to noise ratio as a result of the LSK389's tightly matched gate threshold voltages and low gate

threshold voltages. The 40V breakdown provides maximum linear headroom in high transient program content amplifiers.

Additionally, the LSK389 provides a low input noise to capacitance product that has nearly zero popcorn noise. The narrow ranges of the IDSS electrical grades combined with the superior matching performance of the LSK389's monolithic dual construction promote ease of device tolerance in low voltage applications, as compared to matching single JFETs. Available in surface mount SOIC 8L and thru-hole TO-71 6L packages.

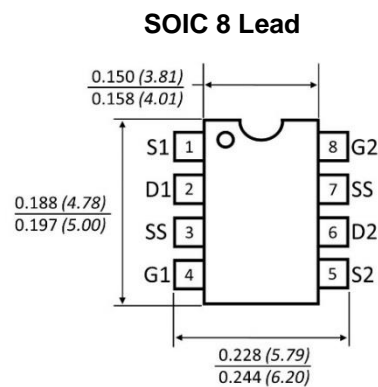
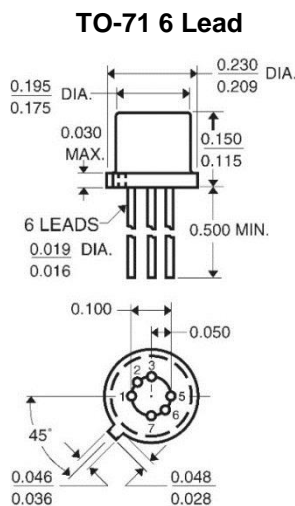
Matching Characteristics @ 25°C (unless otherwise stated)

SYMBOL	CHARACTERISTIC	MIN	TYP	MAX	UNITS	CONDITIONS
$ V_{GS1} - V_{GS2} $	Differential Gate to Source Cutoff Voltage			20	mV	$V_{DS} = 10V, I_D = 1mA$
$\frac{I_{DSS1}}{I_{DSS2}}$	Gate to Source Saturation Current Ratio	0.9			---	$V_{DS} = 10V, V_{GS} = 0V$

Electrical Characteristics @ 25°C (unless otherwise stated)

SYMBOL	CHARACTERISTIC	MIN	TYP	MAX	UNITS	CONDITIONS
BV_{GSS}	Gate to Source Breakdown Voltage	-40			V	$V_{DS} = 0, I_D = -100\mu A$
$V_{GS(OFF)}$	Gate to Source Pinch-off Voltage	-0.15		-2	V	$V_{DS} = 10V, I_D = 0.1\mu A$
I_{DSS}	Drain to Source Saturation Current	LSK389A	2.6	6.5	mA	$V_{DS} = 10V, V_{GS} = 0$
		LSK389B	6	12		
		LSK389C	10	20		
		LSK389D	17	30		
I_{GSS}	Gate to Source Leakage Current			-200	pA	$V_{GS} = -30V, V_{DS} = 0$
I_{G1G2}	Gate to Gate Isolation Current			± 1.0	μA	$V_{G1-G2} = \pm 45V, I_D = I_S = 0A$
G_{fs}	Full Conduction Transconductance	8	20		mS	$V_{DS} = 10V, V_{GS} = 0, f = 1kHz$
e_n	Noise Voltage		1.9		nV/ \sqrt{Hz}	$V_{DS} = 10V, I_D = 2mA, f = 1kHz, NBW = 1Hz$
e_n	Noise Voltage		4.0		nV/ \sqrt{Hz}	$V_{DS} = 10V, I_D = 2mA, f = 10Hz, NBW = 1Hz$
C_{ISS}	Common Source Input Capacitance		25		pF	$V_{DS} = 10V, V_{GS} = 0, f = 1MHz,$
C_{RSS}	Common Source Reverse Transfer Cap.		5.5		pF	$V_{DG} = 10V, I_D = 0, f = 1MHz,$

Package Dimensions



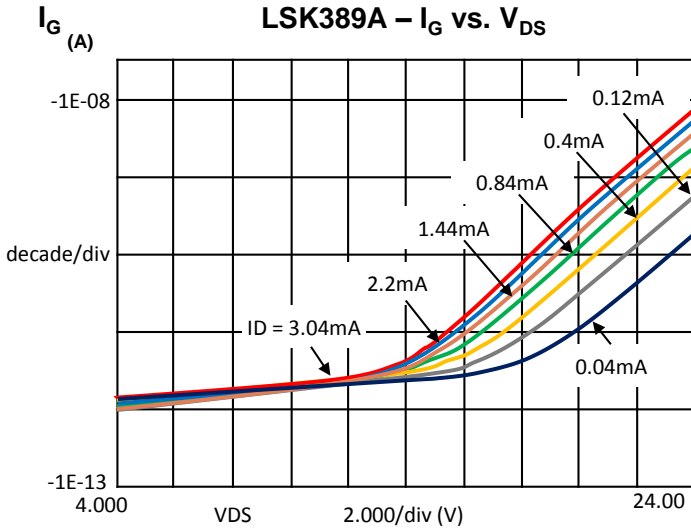
Notes

1. The noise spec is guaranteed by design.
2. Absolute maximum ratings are limiting values above which serviceability may be impaired.
3. Pulse Test: $PW \leq 300\mu s$, Duty Cycle $\leq 3\%$
4. All characteristics MIN/TYP/MAX numbers are absolute values. Negative values indicate electrical polarity only. Information furnished by Linear Integrated Systems is believed to be accurate and reliable. However, no responsibility is assumed for its use; nor for any infringement of patents or other rights of third parties which may result from its use. No license is granted by implication or otherwise under any patent or patent rights of Linear Integrated Systems.

Typical Characteristics

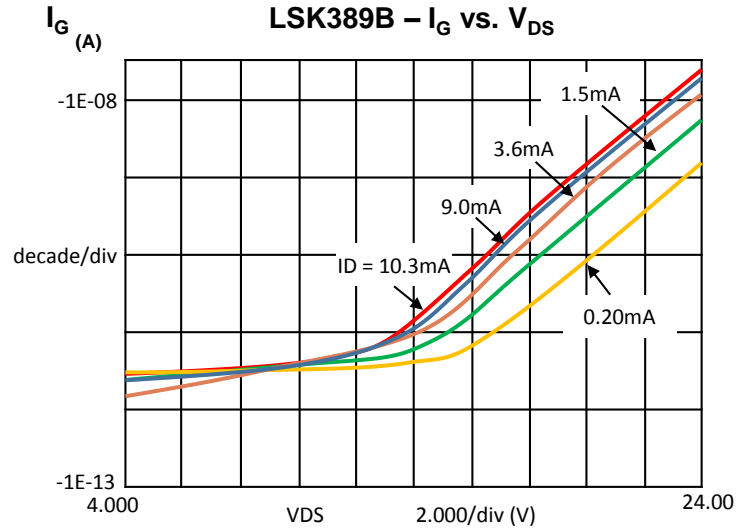
Operating Current

LSK389A – I_G vs. V_{DS}



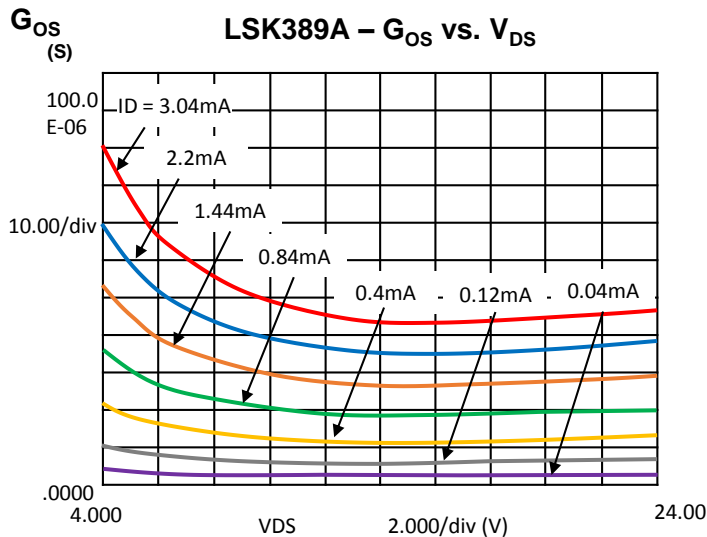
Operating Current

LSK389B – I_G vs. V_{DS}



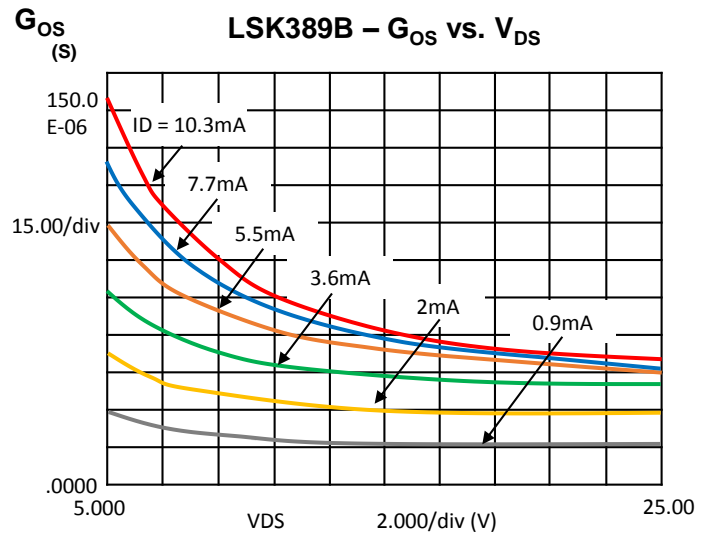
Output Conductance

LSK389A – G_{OS} vs. V_{DS}



Output Conductance

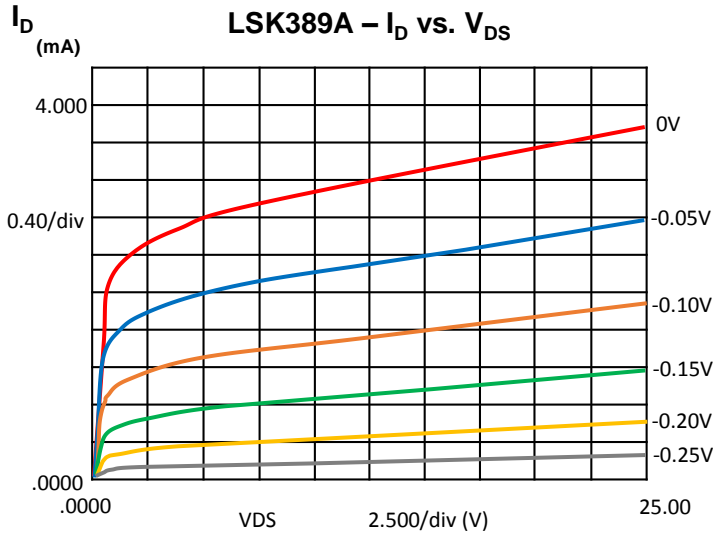
LSK389B – G_{OS} vs. V_{DS}



Typical Characteristics Continued

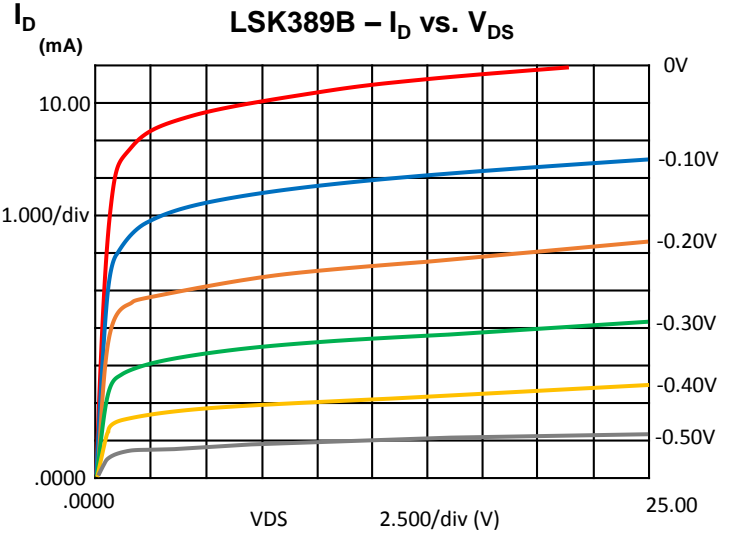
Output Characteristics

LSK389A – I_D vs. V_{DS}



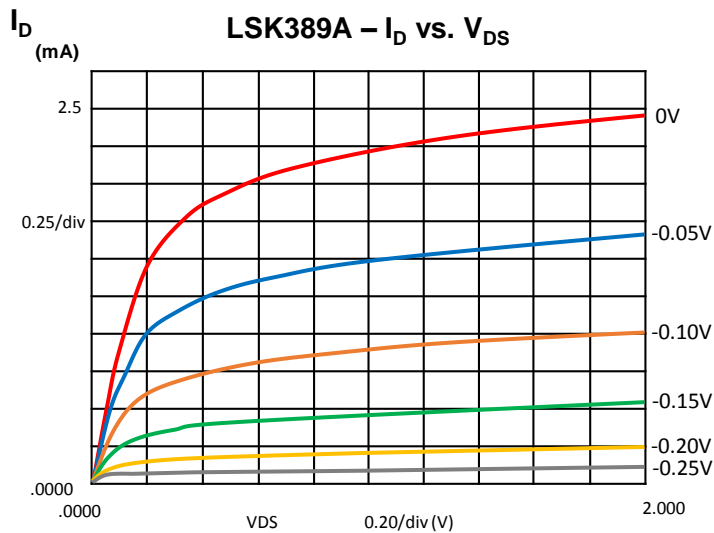
Output Characteristics

LSK389B – I_D vs. V_{DS}



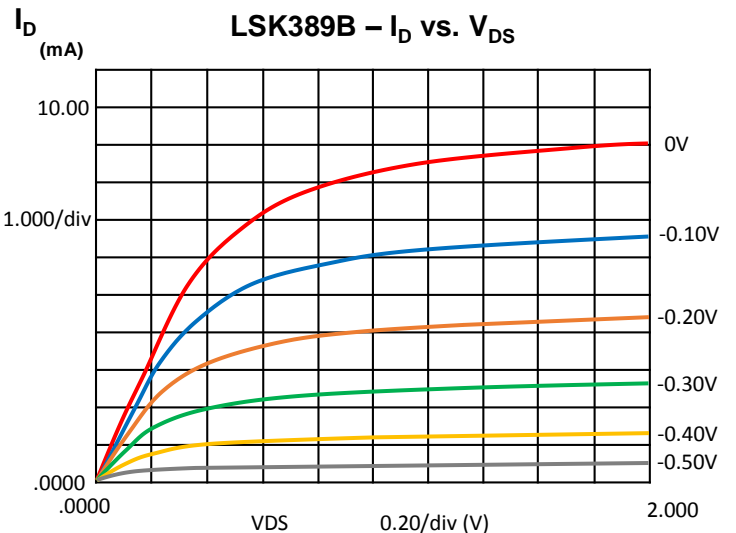
Operating Characteristics

LSK389A – I_D vs. V_{DS}



Operating Characteristics

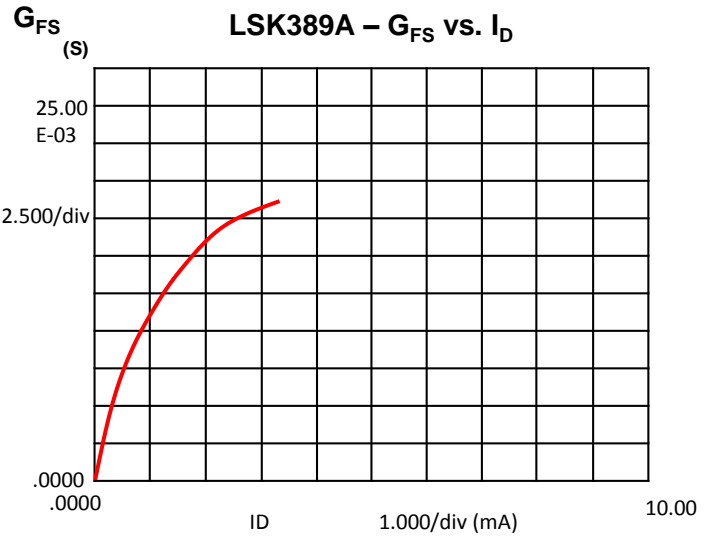
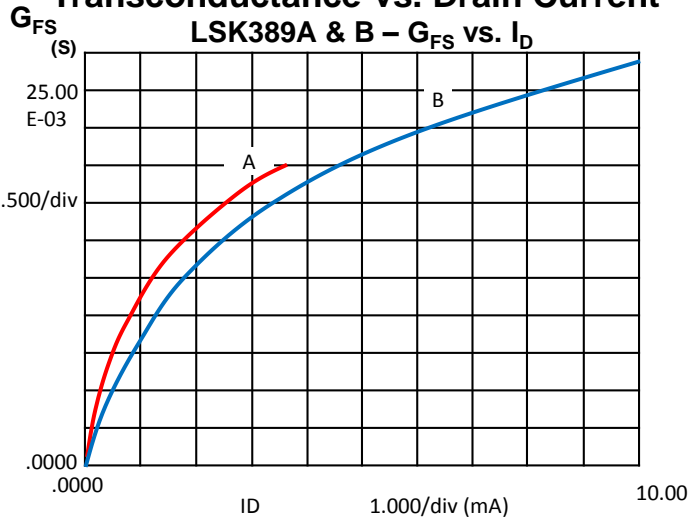
LSK389B – I_D vs. V_{DS}



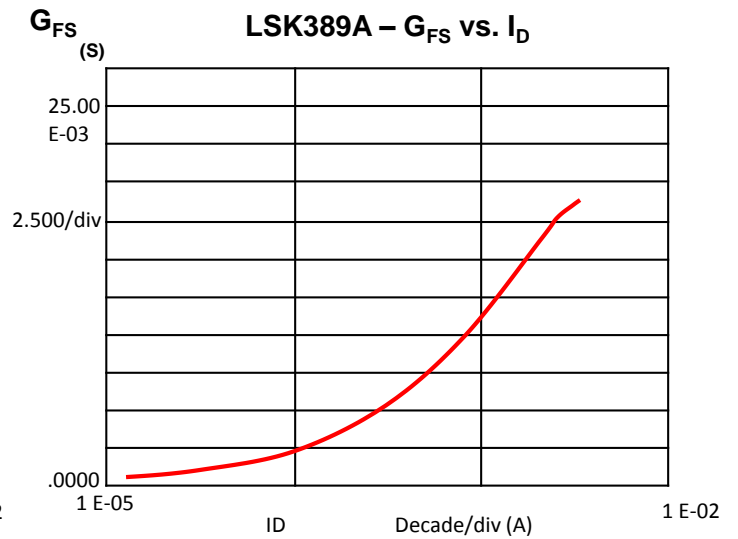
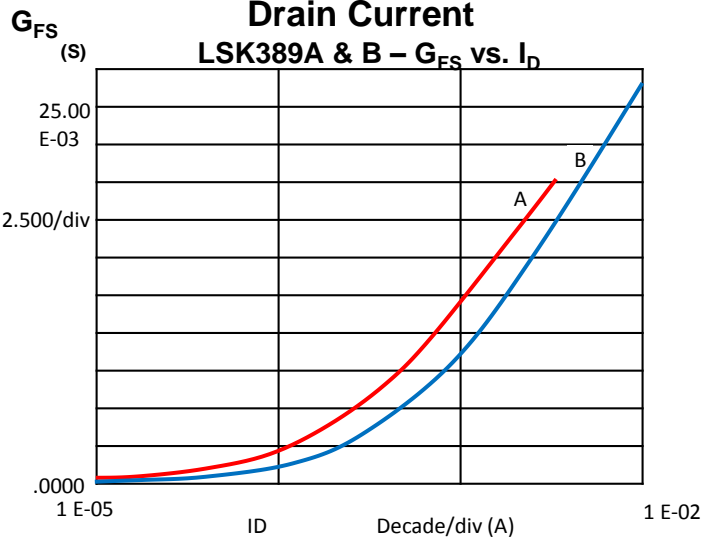
Typical Characteristics Continued

Common Source Forward

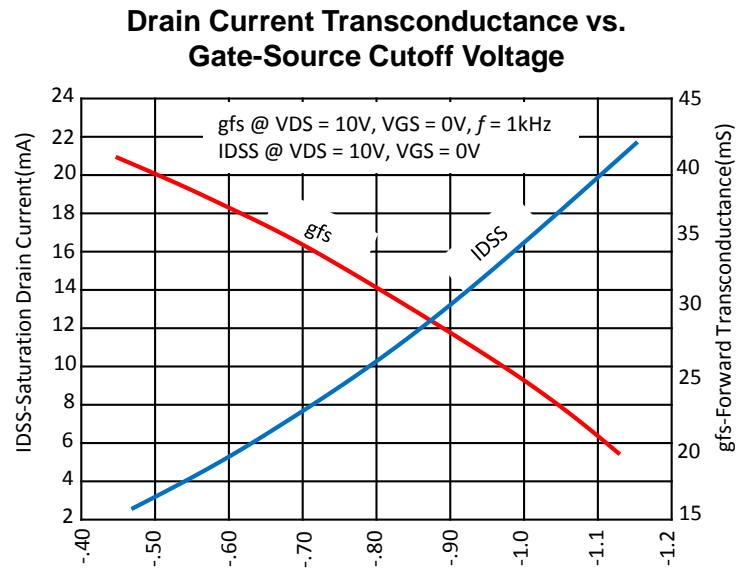
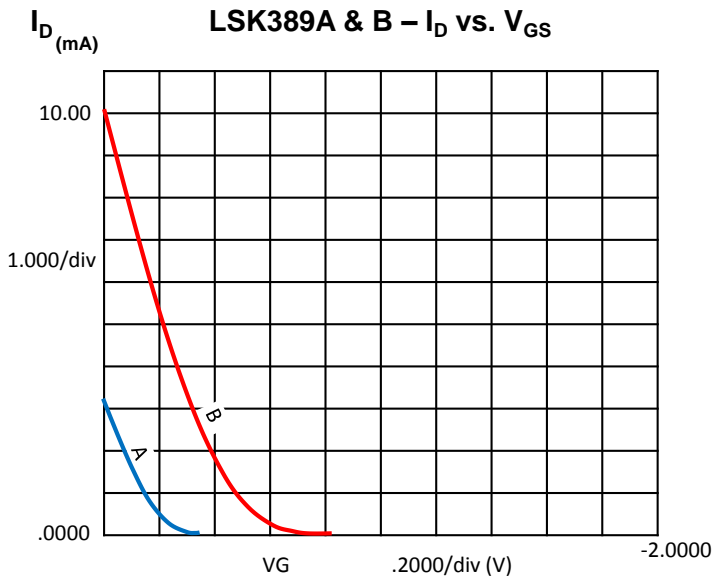
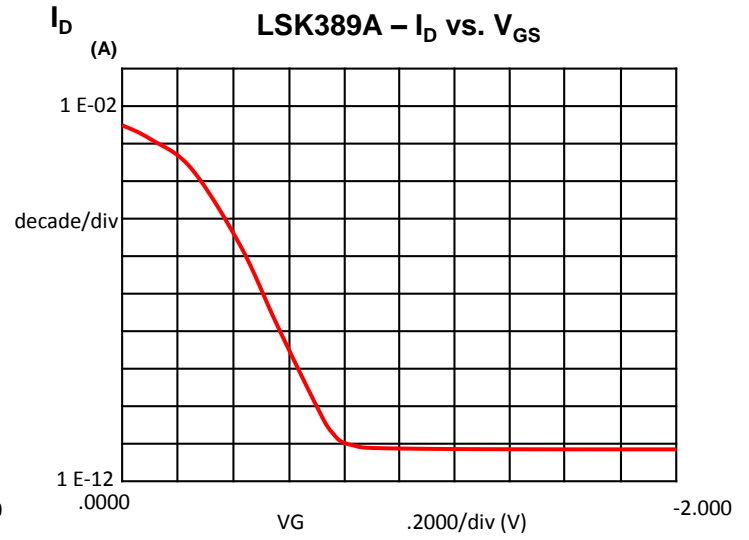
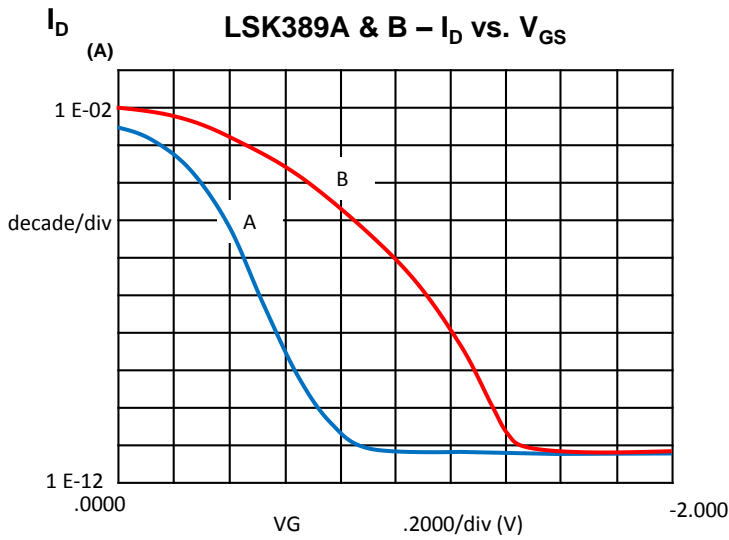
Transconductance vs. Drain Current



Common Source Transconductance vs. Drain Current



Typical Characteristics Continued



Typical Characteristics Continued

Ultra Low Noise Monolithic Dual N-Channel JFET Amplifier

Equivalent Input Noise Voltage vs. Frequency

